

**Search Notes**

Application/Control No.

10/692,588

Examiner

Richard Bueker

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

1763

**SEARCHED**

Class	Subclass	Date	Examiner
118	726; 730	1/23/2005	RRB
above	updated	7/23/2005	RRB
118	727	7/23/2005	RRB
above	updated	12/11/2005	RRB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR